# **Boost Converter Stage in APM16 Series for Multiphase and Semi-Bridgeless PFC with SiC Diodes**

# FAM65CR51AXZ1, FAM65CR51AXZ2

#### Features

- Integrated SIP or DIP Boost Converter Stage Power Module for On-board Charger (OBC) in EV or PHEV
- 5 kV/1 sec Electrically Isolated Substrate for Easy Assembly
- Creepage and Clearance per IEC60664-1, IEC 60950-1
- Compact Design for Low Total Module Resistance
- Module Serialization for Full Traceability
- Lead Free, RoHS and UL94V-0 Compliant
- Automotive Qualified per AEC Q101 and AQG324 Guidelines
- Improved Performance with SiC Diodes

#### Applications

• PFC Stage of an On-board Charger in PHEV or EV

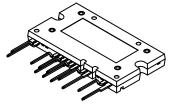
#### Benefits

- Enable Design of Small, Efficient and Reliable System for Reduced Vehicle Fuel Consumption and CO<sub>2</sub> Emission
- Simplified Assembly, Optimized Layout, High Level of Integration, and Improved Thermal Performance

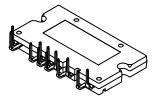


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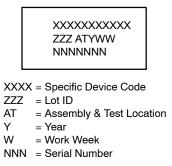


APMCD-A16 12 LEAD CASE MODGG



APMCD-B16 12 LEAD CASE MODGK

#### MARKING DIAGRAM



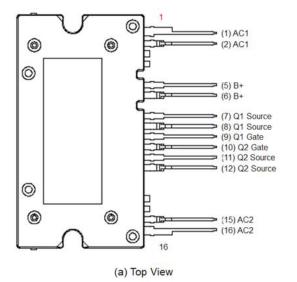
#### **ORDERING INFORMATION**

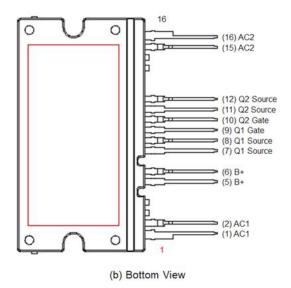
See detailed ordering, marking and shipping information on page 2 of this data sheet.

#### **ORDERING INFORMATION**

Part Number	Package	Lead Forming	DBC Material	Pb–Free and RoHS Compliant	Operating Temperature (T <sub>A</sub> )	Packing Method
FAM65CR51AXZ1	APM16-CDA	Y-Shape	ALN	Yes	–40°C ~ 125°C	Tube
FAM65CR51AXZ2	APM16-CDB	L-Shape	ALN	Yes	$-40^{\circ}C \sim 125^{\circ}C$	Tube

#### **Pin Configuration and Description**







Pin Number	Pin Name	Pin Description	
1, 2	AC1	Phase 1 Leg of the PFC Bridge	
3	NC	Not Connected	
4	NC	Not Connected	
5, 6	B+	Positive Battery Terminal	
7, 8	Q1 Source	Source Terminal of Q1	
9	Q1 Gate	Gate Terminal of Q1	
10	Q2 Gate	Gate Terminal of Q2	
11, 12	Q2 Source	Source Terminal of Q2	
13	NC	Not Connected	
14	NC	Not Connected	
15, 16	AC2	Phase 2 Leg of the PFC Bridge	

#### Table 1. PIN DESCRIPTION

#### INTERNAL EQUIVALENT CIRCUIT

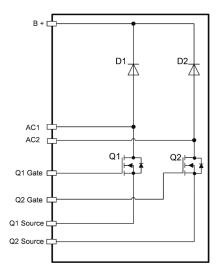


Figure 2. Internal Block Diagram

#### Table 2. ABSOLUTE MAXIMUM RATINGS OF MOSFET (T<sub>J</sub> = 25°C, Unless Otherwise Specified)

Symbol	Parameter	Мах	Unit
V <sub>DS</sub> (Q1~Q2)	Drain-to-Source Voltage	650	V
V <sub>GS</sub> (Q1~Q2)	Gate-to-Source Voltage	±20	V
I <sub>D</sub> (Q1~Q2)	Drain Current Continuous ( $T_C$ = 25°C, $V_{GS}$ = 10 V) (Note 1)	64	А
	Drain Current Continuous (T <sub>C</sub> = 100°C, V <sub>GS</sub> = 10 V) (Note 1)	40	А
E <sub>AS</sub> (Q1~Q2)	Single Pulse Avalanche Energy (Note 2)	623	mJ
PD	Power Dissipation (Note 1)	463	W
TJ	Maximum Junction Temperature	–55 to +150	°C
Т <sub>С</sub>	Maximum Case Temperature	-40 to +125	°C
T <sub>STG</sub>	Storage Temperature	-40 to +125	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Maximum continuous current and power, without switching losses, to reach  $T_J = 150^{\circ}C$  respectively at  $T_C = 25^{\circ}C$  and  $T_C = 100^{\circ}C$ ; defined by design based on MOSFET  $R_{DS(ON)}$  and  $R_{\theta JC}$  and not subject to production test

2. Starting  $T_J = 25^{\circ}C$ ,  $I_{AS} = 6.5 \text{ A}$ ,  $R_G = 25 \Omega$ 

#### **DBC Substrate**

0.63 mm ALN alumina with 0.3 mm copper on both sides. DBC substrate is NOT nickel plated.

#### Lead Frame

OFC copper alloy, 0.50 mm thick. Plated with  $8\,\mu\text{m}$  to 25.4  $\mu\text{m}$  thick Matte Tin

#### **Flammability Information**

All materials present in the power module meet UL flammability rating class 94V–0.

#### **Compliance to RoHS Directives**

The power module is 100% lead free and RoHS compliant 2000/53/C directive.

#### Solder

Solder used is a lead free SnAgCu alloy.

Solder presents high risk to melt at temperature beyond 210°C. Base of the leads, at the interface with the package body, should not be exposed to more than 200°C during mounting on the PCB or during welding to prevent the re-melting of the solder joints.

#### Table 3. ELECTRICAL SPECIFICATIONS OF MOSFET (T<sub>J</sub> = 25°C, Unless Otherwise Specified)

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
BV <sub>DSS</sub>	Drain-to-Source Breakdown Voltage	I <sub>D</sub> = 1 mA, V <sub>GS</sub> = 0 V	650	-	-	V
V <sub>GS(th)</sub>	Gate-to-Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 3.3 \text{ mA}$	3.0	-	5.0	V
R <sub>DS(ON)</sub> Q1	Q1 Low Side MOSFET	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 20 \text{ A}$	-	44	51	mΩ
R <sub>DS(ON)</sub> Q2	Q2 Low Side MOSFET		-	44	51	mΩ
R <sub>DS(ON)</sub> Q1	Q1 Low Side MOSFET	$V_{GS}$ = 10 V, I <sub>D</sub> = 20 A, T <sub>J</sub> = 125°C (Note 3)	-	79	-	mΩ
R <sub>DS(ON)</sub> Q2	Q2 Low Side MOSFET		-	79	-	mΩ
<b>g</b> fs	Forward Transconductance	V <sub>DS</sub> = 20 V, I <sub>D</sub> = 20 A (Note 3)	-	30	-	S
I <sub>GSS</sub>	Gate-to-Source Leakage Current	$V_{GS}$ = ±20 V, $V_{DS}$ = 0 V	-100	-	+100	nA
I <sub>DSS</sub>	Drain-to-Source Leakage Current	$V_{DS} = 650 \text{ V}, V_{GS} = 0 \text{ V}$	-	-	10	μA
DYNAMIC CHA	ARACTERISTICS (Note 3)					
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 400 V	-	4864	-	pF
C <sub>oss</sub>	Output Capacitance	V <sub>GS</sub> = 0 V f = 1 MHz	-	109	-	pF
C <sub>rss</sub>	Reverse Transfer Capacitance		-	16	-	pF
C <sub>oss(eff)</sub>	Effective Output Capacitance	V <sub>DS</sub> = 0 to 520 V V <sub>GS</sub> = 0 V	_	652	-	pF
R <sub>g</sub>	Gate Resistance	f = 1 MHz	-	2	-	Ω
Q <sub>g(tot)</sub>	Total Gate Charge	V <sub>DS</sub> = 380 V	-	123	-	nC
Q <sub>gs</sub>	Gate-to-Source Gate Charge	I <sub>D</sub> = 20 A V <sub>GS</sub> = 0 to 10 V	-	37.5	-	nC
Q <sub>gd</sub>	Gate-to-Drain "Miller" Charge	VGS = 010 10 V	-	49	-	nC
SWITCHING C	HARACTERISTICS (Note 3)					
t <sub>on</sub>	Turn-on Time	V <sub>DS</sub> = 400 V	-	87	-	ns
t <sub>d(on)</sub>	Turn-on Delay Time	I <sub>D</sub> = 20 A V <sub>GS</sub> = 10 V	-	47	-	ns
t <sub>r</sub>	Turn-on Rise Time	$V_{GS} = 10 V$ $R_G = 4.7 Ohm$	-	43	-	ns
t <sub>off</sub>	Turn-off Time		-	146	-	ns
t <sub>d(off)</sub>	Turn-off Delay Time		-	118	-	ns
t <sub>f</sub>	Turn-off Fall Time		-	29	-	ns
BODY DIODE	CHARACTERISTICS	•		•	•	
V <sub>SD</sub>	Source-to-Drain Diode Voltage	I <sub>SD</sub> = 20 A, V <sub>GS</sub> = 0 V	-	0.95	-	V

V <sub>SD</sub>	Source-to-Drain Diode Voltage	$I_{SD} = 20 \text{ A}, \text{ V}_{GS} = 0 \text{ V}$	-	0.95	-	V	
T <sub>rr</sub>	Reverse Recovery Time	$V_{DS} = 520 \text{ V}, I_D = 20 \text{ A},$	-	133	-	ns	
Q <sub>rr</sub>	Reverse Recovery Charge	d <sub>I</sub> /d <sub>t</sub> = 100 A/μs (Note 3)	-	669	-	nC	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 3. Defined by design, not subject to production test

Symbol	Parameter	Rating	Unit
V <sub>RRM</sub>	Peak Repetitive Reverse Voltage (Note 4)	650	V
E <sub>AS</sub>	Avalanche Energy (17 A, 1 mH)	144	mJ
I <sub>F</sub>	Continuous Rectified Forward Current, T <sub>C</sub> < 148°C	30	Α
I <sub>F,MAX</sub>	Non–Repetitive Forward Surge Current, $T_C = 25^{\circ}C$ , 10 $\mu$ s	1100	А
I <sub>F,MAX</sub>	Non–Repetitive Forward Surge Current, $T_C = 150^{\circ}C$ , 10 $\mu$ s	1000	Α
I <sub>FSM</sub>	Non-Repetitive Peak Surge Current (Sine Half Wave, Tp = 8.3 ms)	110	Α
PD	Power Dissipation ( $T_C = 25^{\circ}C$ )	166	W
TJ	Maximum Junction Temperature	–55 to +175	°C
T <sub>C</sub>	Maximum Case Temperature	-40 to +125	°C
T <sub>STG</sub>	Storage Temperature	-40 to +125	°C

#### Table 4. ABSOLUTE MAXIMUM RATINGS OF THE BOOST DIODE (T<sub>J</sub> = 25°C, Unless Otherwise Specified)

4. V<sub>RRM</sub> and I<sub>F</sub> value referenced to TO220-2L Auto Qualified Package Device FFSP3065B\_F085

#### Table 5. ELECTRICAL SPECIFICATIONS OF THE BOOST DIODE (T<sub>J</sub> = 25°C, Unless Otherwise Specified)

Symbol	Parameter	Test Cond	ditions	Min	Тур	Max	Unit
V <sub>DC</sub>	DC Blocking Voltage	I <sub>R</sub> = 200 μA	$T_{C} = 25^{\circ}C$	650	-	-	V
V <sub>F</sub>	Instantaneous Forward Voltage	I <sub>F</sub> = 30 A	$T_{C} = 25^{\circ}C$	-	1.38	1.7	V
			T <sub>C</sub> = 125°C	-	1.6	2.0	V
			T <sub>C</sub> = 175°C	-	1.72	2.4	V
I <sub>R</sub>	Instantaneous Reverse Current	V <sub>R</sub> = 650 V	$T_{C} = 25^{\circ}C$	-	0.5	40	μA
			T <sub>C</sub> = 125°C	-	1.0	80	μA
			T <sub>C</sub> = 175°C	-	2.0	160	μA
$Q_{C}$	Total Capacitive Charge	V <sub>R</sub> = 400 V	$T_{C} = 25^{\circ}C$	-	43	-	nC
С	Total Capacitance	V <sub>R</sub> = 1 V	f = 100 kHz		1280		pF
		V <sub>R</sub> = 200 V	f = 100 kHz		139		
		V <sub>R</sub> = 400 V	f = 100 kHz		108		

#### **Table 6. THERMAL RESISTANCE**

	Parameters		Тур	Max	Unit
$R_{\theta JC}$ (per MOSFET chip)	Q1,Q2 Thermal Resistance Junction-to-Case (Note 5)	-	0.19	0.27	°C/W
$R_{\theta JS}$ (per MOSFET chip)	Q1,Q2 Thermal Resistance Junction-to-Sink (Note 6)	-	0.61	-	°C/W
$R_{\theta JC}$ (per DIODE chip)	D1,D2 Thermal Resistance Junction-to-Case (Note 5)	-	0.7	0.9	°C/W
$R_{\theta JS}$ (per DIODE chip)	D1,D2 Thermal Resistance Junction-to-Sink (Note 6)	-	1.73	-	°C/W

5. Test method compliant with MIL STD 883-1012.1, from case temperature under the chip to case temperature measured below the package at the chip center, Cosmetic oxidation and discoloration on the DBC surface allowed 6. Defined by thermal simulation assuming the module is mounted on a 5 mm Al–360 die casting material with 30 um of 1.8 W/mK thermal

interface material

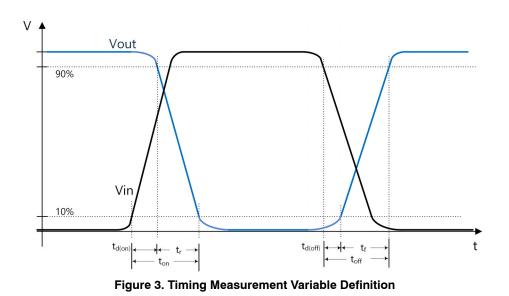
Table 7. ISOLATION	solation resistance at tested voltage between the base plate and to control pins or power terr	ninals.)

Test	Test Conditions	Isolation Resistance	Unit
Leakage @ Isolation Voltage (Hi-Pot)	V <sub>AC</sub> = 5 kV, 50 Hz	100M <	Ω

## PARAMETER DEFINITIONS

Reference to Table 3: Parameter of MOSFET Electrical Specifications

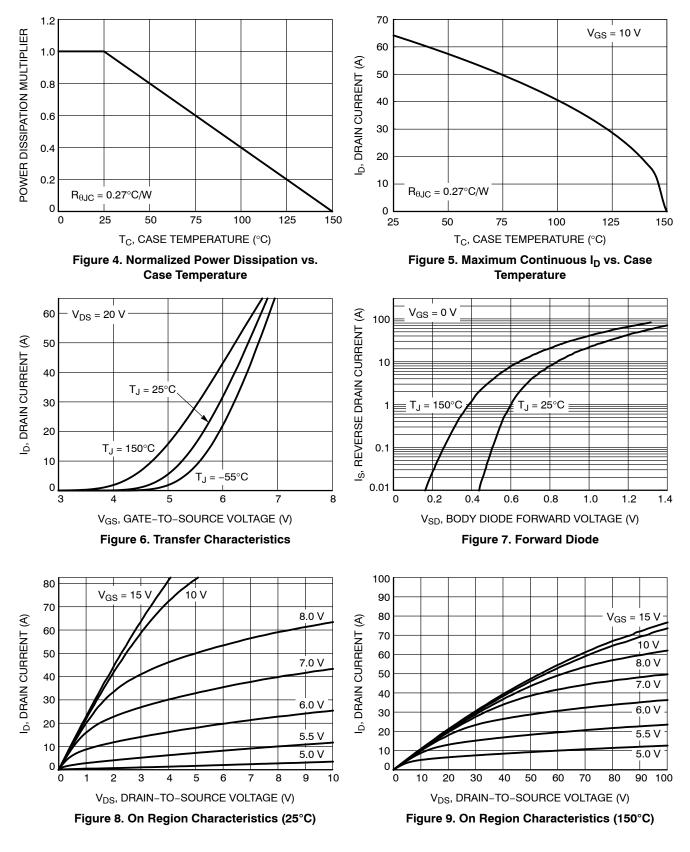
BV <sub>DSS</sub>	Q1, Q2 MOSFET Drain-to-Source Breakdown Voltage The maximum drain-to-source voltage the MOSFET can endure without the avalanche breakdown of the body- drain P-N junction in off state. The measurement conditions are to be found in Table 3. The typ. Temperature behavior is described in Figure 13
V <sub>GS(th)</sub>	Q1, Q2 MOSFET Gate to Source Threshold Voltage The gate-to-source voltage measurement is triggered by a threshold ID current given in conditions at Table 4. The typ. Temperature behavior can be found in Figure 10
R <sub>DS(ON)</sub>	Q1, Q2 MOSFET On Resistance RDS(on) is the total resistance between the source and the drain during the on state. The measurement conditions are to be found in Table 3. The typ behavior can be found in Figure 11 and Figure 12 as well as Figure 17
9fs	Q1, Q2 MOSFET Forward Transconductance Transconductance is the gain in the MOSFET, expressed in the Equation below. It describes the change in drain current by the change in the gate-source bias voltage: $g_{fs} = [\Delta I_{DS} / \Delta V_{GS}]_{VDS}$
I <sub>GSS</sub>	Q1, Q2 MOSFET Gate-to-Source Leakage Current The current flowing from Gate to Source at the maximum allowed VGS The measurement conditions are described in the Table 3.
I <sub>DSS</sub>	Q1, Q2 MOSFET Drain-to-Source Leakage Current Drain – Source current is measured in off state while providing the maximum allowed drain-to-source voltage and the gate is shorted to the source. IDSS has a positive temperature coefficient.

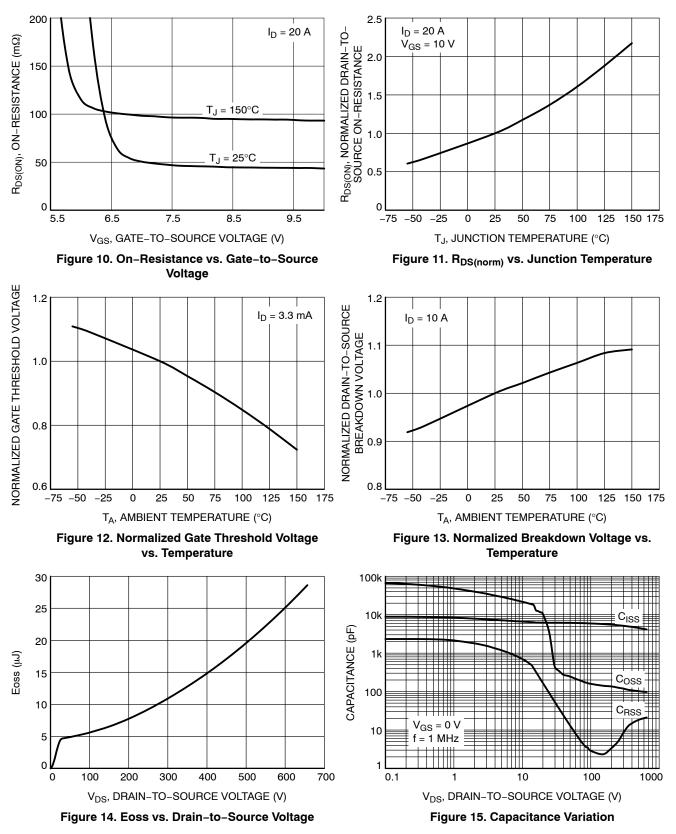


#### Table 8. PARAMETER OF SWITCHING CHARACTERISTICS

Turn-On Delay (t <sub>d(on)</sub> )	This is the time needed to charge the input capacitance, Ciss, before the load current ID starts flowing. The measurement conditions are described in the Table 3. For signal definition please check Figure 3 above.
Rise Time (t <sub>r</sub> )	The rise time is the time to discharge output capacitance, Coss. After that time the MOSFET conducts the given load current ID. The measurement conditions are described in the Table 3. For signal definition please check Figure 3 above.
Turn–On Time (t <sub>on</sub> )	Is the sum of turn-on-delay and rise time
Turn-Off Delay (t <sub>d(off)</sub> )	td(off) is the time to discharge Ciss after the MOSFET is turned off. During this time the load current ID is still flowing
	The measurement conditions are described in the Table 3. For signal definition please check Figure 3 above.
Fall Time (t <sub>f</sub> )	The fall time, tf, is the time to charge the output capacitance, Coss. During this time the load current drops down and the voltage VDS rises accordingly. The measurement conditions are described in the Table 3. For signal definition please check Figure 3 above.
Turn–Off Time (t <sub>off</sub> ):	Is the sum of turn-off-delay and fall time

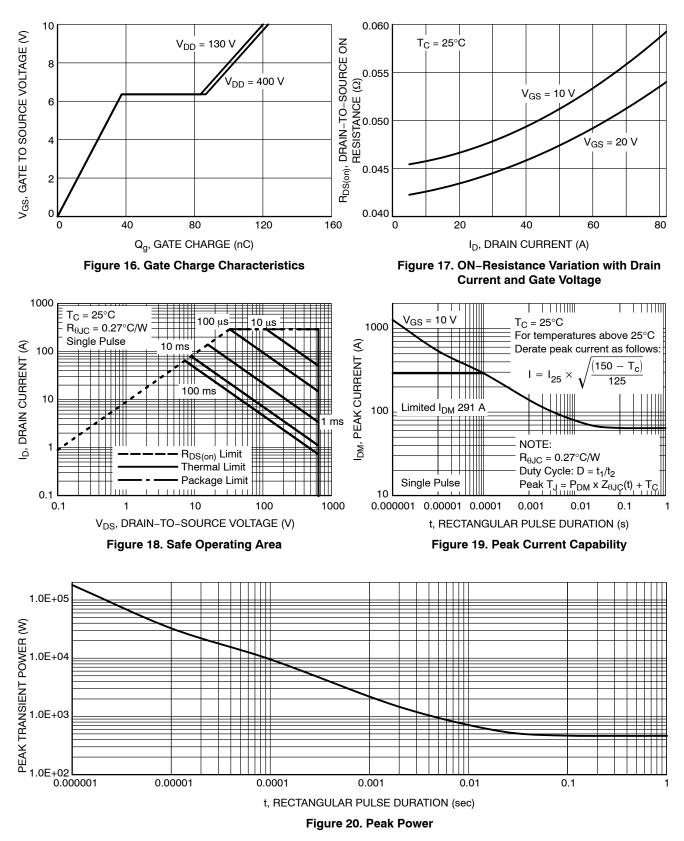
#### **TYPICAL CHARACTERISTICS – MOSFETs**



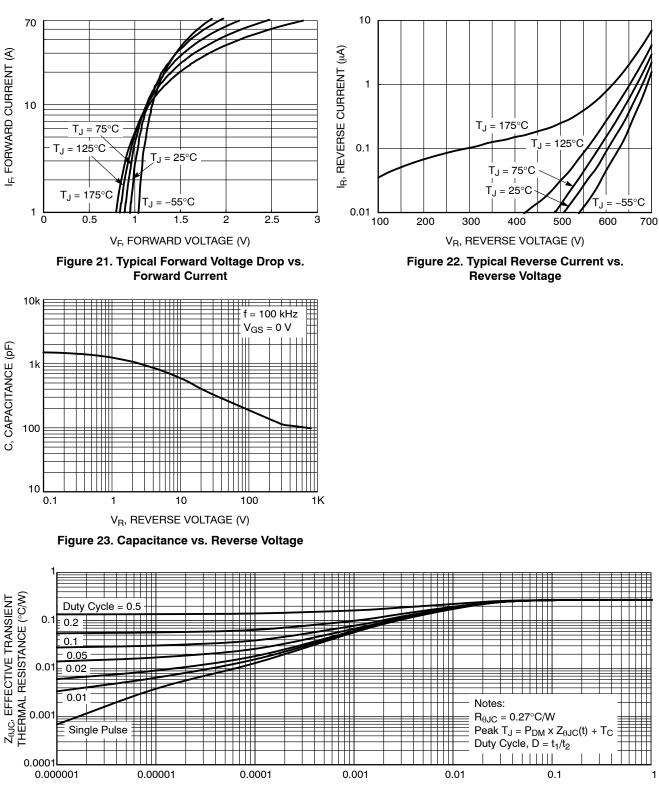


#### **TYPICAL CHARACTERISTICS – MOSFETs**

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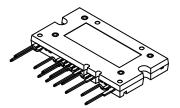


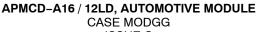
**TYPICAL CHARACTERISTICS – DIODES** 



t, RECTANGULAR PULSE DURATION (s) Figure 24. Transient Thermal Impedance

#### **MECHANICAL CASE OUTLINE** PACKAGE DIMENSIONS





ISSUE C

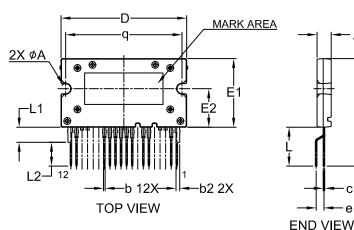
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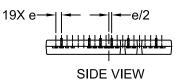
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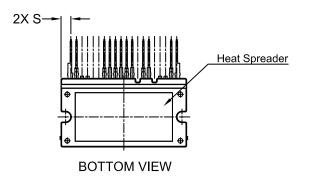
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DATE 03 NOV 2021

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NOTES:

- 1. DIMENSIONING AND TOLERANCING PER. ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR EXTRUSIONS.

	MILLIMETERS			
DIM	MIN.	NOM.	MAX.	
A2	4.30	4.50	4.70	
b	0.45	0.50	0.60	
b2	1.15	1.20	1.30	
С	0.45	0.50	0.60	
D	39.90	40.10	40.30	
Ш	33.80	34.30	34.80	
E1	21.70	21.90	22.10	
E2	12.10	12.30	12.50	
е	1.478	1.778	2.078	
e1	2.20	2.50	2.80	
L	12.10	12.40	12.70	
L1	4.80 REF			
L2	7.30	7.60	7.90	
q	36.85	37.10	37.35	
S	3.159 REF			
ØΑ	3.00	3.20	3.40	

GENERIC **MARKING DIAGRAM\*** 

ZZZ ATYWW

NNNNNN

XXXX = Specific Device Code ZZZ = Lot ID = Assembly & Test Location

AT Υ = Year

WW

= Work Week

NNN = Serial Number

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

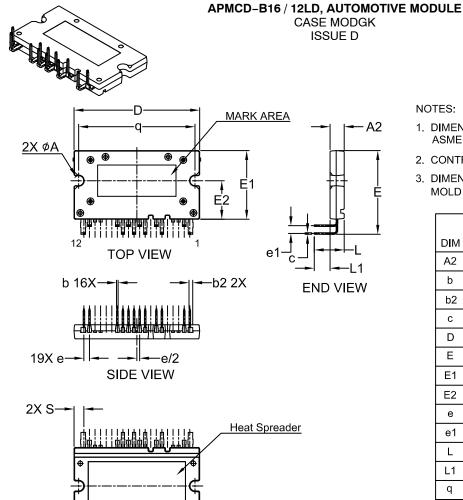
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#### **MECHANICAL CASE OUTLINE** PACKAGE DIMENSIONS

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DATE 04 NOV 2021



BOTTOM VIEW

#### NOTES:

- 1. DIMENSIONING AND TOLERANCING PER. ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION; MILLIMETERS
- 3. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR EXTRUSIONS.

	MILLIMETERS			
DIM	MIN.	NOM.	MAX.	
A2	4.30	4.50	4.70	
b	0.45	0.50	0.60	
b2	1.15	1.20	1.30	
с	0.45	0.50	0.60	
D	39.90	40.10	40.30	
E	26.20	26.70	27.20	
E1	21.70	21.90	22.10	
E2	12.10	12.30	12.50	
е	1.478	1.778	2.078	
e1	2.20	2.50	2.80	
L	9.20	9.55	9.90	
L1	4.70	5.05	5.40	
q	36.85	37.10	37.35	
S	3.159 REF			
ØΑ	3.00	3.20	3.40	

#### GENERIC **MARKING DIAGRAM\***

777 ATYWW NNNNNN

XXXX = Specific Device Code ZZZ = Lot ID

- AT = Assembly & Test Location
- Υ = Year W
  - = Work Week
- NNN = Serial Number

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